



### 3.3V 64K x 32 Fast CMOS Synchronous Static RAM with Burst Counter

#### **Features**

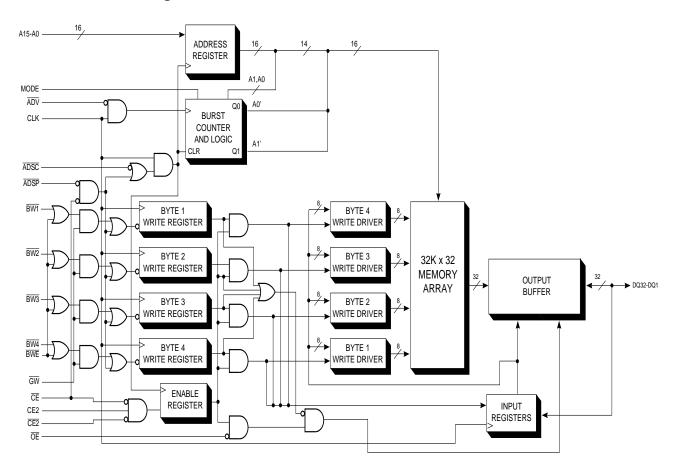
Ш	Interfaces directly with the x86, Pentium <sup>131</sup> , 680X
	and PowerPC <sup>TM</sup> processors
	Single 3.3V power supply
	Mode selectable for interleaved or linear burst:
	Interleaved for x86 and Pentium
	Linear for 680x0 and PowerPC
	Fast access times:
	9, 10, 12 and 15 ns
	High-density 64K x 32 architecture with burst
	address counter
	Fully registered inputs
	High-output drive: 30 pF at rated T <sub>A</sub>
	Asynchronous output enable
	Self-timed write cycle
	Separate byte write enables and one global write
	enable
	Internal burst read/write address counter
	Internal registers for address, data, controls
	Burst mode selectable
	Sleep mode
	Packages:
	100-pin QFP - (Q)
	100-pin TQFP - (TQ)

#### Description

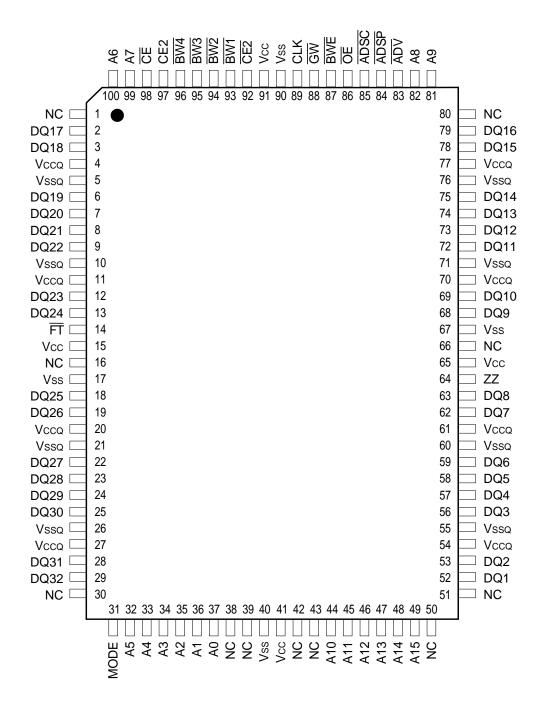
The PDM34089 is a 2,097,152 bit synchronous random access memory organized as 65,536 x 32 bits. It is designed with burst mode capability and interface controls to provide high-performance in second level cache designs for x86, Pentium, 680x0, and PowerPC microprocessors. Addresses, write data and all control signals except output enable are controlled through positive edge-triggered registers. Write cycles are self-timed and are also initiated by the rising edge of the clock. Controls are provided to allow burst reads and writes of up to four words in length. A 2-bit burst address counter controls the two least-significant bits of the address during burst reads and writes. The burst address counter selectively uses the 2-bit counting scheme required by the x86 and Pentium or 680x0 and PowerPC microprocessors as controlled by the mode pin. Individual write strobes provide byte write for the four 8-bit bytes of data. An asynchronous output enable simplifies interface to high-speed buses.

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# **Functional Block Diagram**



#### PDM34089 Pinout





#### **Pinout**

Name	I/O	Description	Name	I/O	Description
A14-A2	I	Address Inputs A14-A2	CE, CE2, CE2	I	Chip Enables
A1, A0	ı	Address Inputs A1 & A0	BWE	I	Byte Write Enable
DQ1-DQ32	I/O	Read/Write Data	BW1-BW4	I	Byte Write Enables
NC	_	No Connect	ŌĒ	I	Output Enable
MODE <sup>(1)</sup>	I	Burst Sequence Select	CLK	I	Clock
ADV	I	Burst Counter Advance	ZZ	I	Sleep Mode
ADSC	ı	Controller Address Status	V <sub>CC</sub>	_	Power Supply (+3.3V)
ADSP	ı	Processor Address Status	V <sub>CCQ</sub>	_	Output Power for DQ's (+3.3V ±5%)
GW	I	Global Write	V <sub>SS</sub>	_	Array Ground
FT <sup>(1)</sup>	I	Must be tied LOW for proper operation	V <sub>SSQ</sub>	_	Output Ground for DQ's

Note: 1.MODE and FT are DC operated pins. Do not alter input state while device is operating.

### **Burst Sequence Table**

Burst Sequence	Interleaved <sup>(1)</sup> Mode = NC or V <sub>CC</sub>	Linear <sup>(2)</sup> Mode = V <sub>SS</sub>				
External Address	A15-A2, A1, A0	A15-A2,0,0	A15-A2,0,1	A15-A2,1,0	A15-A2,1,1	
1st Burst Address	A15-A2, A1, A0	A15-A2,0,1	A15-A2,1,0	A15-A2,1,1	A15-A2,0,0	
2nd Burst Address	A15-A2, A1, A0	A15-A2,1,0	A15-A2,1,1	A15-A2,0,0	A15-A2,0,1	
3rd Burst Address	A15-A2, A1, A0	A15-A2,1,1	A15-A2,0,0	A15-A2,0,1	A15-A2,1,0	

Note:

- 1. Interleaved = x86 and Pentium.
- 2. Linear = 680x0 and PowerPC compatible.

# **Asynchronous Truth Table**

Operation	ZZ	ŌĒ	I/O Status
Read	L	L	Data Out
Read	L	Н	High-Z
Write	L	Х	High-Z: Write Data In
Deselected	L	Х	High-Z
Sleep	Н	Х	High-Z

- NOTE: 1. L = Low, H = High, X = Don't Care.
  - 2. For a write operation following a read operation, OE must be high before the input data required setup time and held high through the input data hold time.
  - 3. This device contains circuitry that will ensure the outputs will be in high-Z during powerup.

### **Partial Truth Table for Writes**

GW	BWE	BW1	BW2	BW3	BW4	Function
Н	Н	Х	Х	Х	Х	READ
Н	L	Н	Н	Н	Н	READ
Н	L	L	Н	Н	Н	WRITE Byte 1
Н	L	L	L	L	L	WRITE All Bytes
L	Х	Х	Х	Х	Х	WRITE All Bytes

- NOTE: 1. L = Low, H = High, X = Don't Care.
  - 2. Using BWE and BW1 through BW4, any one or more bytes may be written.



### Synchronous Truth Table (See Notes 1 through 3)

CE	CE2	CE2	ADSP	ADSC	ADV	BWx	CLK	Address	Operation
Н	Х	Х	Х	L	Х	Х	1	N/A	Deselected
L	Х	L	L	Х	Х	Х	1	N/A	Deselected
L	Н	Х	L	Х	Х	Х	1	N/A	Deselected
L	Х	L	Н	L	Х	Х	1	N/A	Deselected
L	Н	Х	Н	L	Х	Х	1	N/A	Deselected
L	L	Н	L	Х	Х	Х	1	External	Read Cycle, Begin Burst
L	L	Н	Н	L	Х	Х	1	External	Read Cycle, Begin Burst
Х	Х	Х	Н	Н	L	Н	1	Next	Read Cycle, Continue Burst
Н	Х	Х	Х	Н	L	Н	1	Next	Read Cycle, Continue Burst
Х	Х	Х	Н	Н	Н	Н	1	Current	Read Cycle, Suspend Burst
Н	Х	Х	Х	Н	Н	Н	1	Current	Read Cycle, Suspend Burst
L	L	Н	Н	L	Х	L	1	External	Write Cycle, Begin Burst
Х	Х	Х	Н	Н	L	L	1	Next	Write Cycle, Continue Burst
Н	Х	Х	Х	Н	L	L	1	Next	Write Cycle, Continue Burst
Х	Х	Х	Н	Н	Н	L	1	Current	Write Cycle, Suspend Burst
Н	Х	Х	Н	Н	Н	L	1	Current	Write Cycle, Suspend Burst

#### NOTES:

- 1. X = Don't Care, H = logic High, L = logic Low,  $\overline{BWx}$  = any one or more byte write enable signals ( $\overline{BW1}$ ,  $\overline{BW2}$ ,  $\overline{BW3}$ ,  $\overline{BW4}$ ) and  $\overline{BWE}$  are low, or  $\overline{GW}$  is low.
- 2.  $\overline{BW1}$  enables  $\overline{BWx}$  to Byte 1 (DQ1-DQ8).  $\overline{BW2}$  enables  $\overline{BWx}$  to Byte 2 (DQ9-DQ16).  $\overline{BW3}$  enables  $\overline{BWx}$  to Byte 3 (DQ17-DQ24),  $\overline{BW4}$  enables  $\overline{BWx}$  to Byte 4 (DQ25-DQ32).
- 3. ADV must always be high at the rising edge of the first clock after an ADSP cycle is initiated if a write cycle is desired (to ensure use of correct address).



#### **Burst Mode Operation**

This is a synchronous part. All activities are initiated by the positive, low-to-high edge of the clock (CLK). This part can perform burst reads and writes with burst lengths of up to four words. The four-word burst is created by using a burst counter to drive the two least-significant bits of the internal RAM address. The burst counter is loaded at the start of the burst and is incremented for each word of the burst. The sequence is given in the Burst Sequence Table.

Burst transfers are initiated by the  $\overline{ADSC}$  or  $\overline{ADSP}$  signals. When the  $\overline{ADSP}$  and  $\overline{CE}$  signals are sampled low, a read cycle is started (independent of  $\overline{BW1}$ ,  $\overline{BW2}$ ,  $\overline{BW3}$  or  $\overline{BW4}$ ;  $\overline{BWE}$ ,  $\overline{GW}$  and  $\overline{ADSC}$ ), and prior burst activity is terminated.  $\overline{ADSP}$  is gated by  $\overline{CE}$ , so both must be active for  $\overline{ADSP}$  to load the address register and to initiate a read cycle. The address and the chip enable input ( $\overline{CE}$ ) are sampled by the same edge that samples  $\overline{ADSP}$ . Read data is valid at the output after the specified delay from the clock edge.

When  $\overline{ADSC}$  is sampled low and  $\overline{ADSP}$  is sampled high, a read or write cycle is started depending on the state of  $\overline{BW1}$ ,  $\overline{BW2}$ ,  $\overline{BW3}$  or  $\overline{BW4}$ ;  $\overline{BWE}$ , and  $\overline{GW}$ . If  $\overline{BW1}$ ,  $\overline{BW2}$ ,  $\overline{BW2}$ ,  $\overline{BW3}$ ,  $\overline{BW4}$ ,  $\overline{BWE}$ , and  $\overline{GW}$  are all sampled high, a read cycle is started, as described above. If  $\overline{BW1}$ ,  $\overline{BW2}$ ,  $\overline{BW3}$ , or  $\overline{BW4}$ ;  $\overline{BWE}$ , and  $\overline{GW}$  is sampled low, a write cycle is begun. The address, write data, and the chip enable inputs ( $\overline{CE}$ ,  $\overline{CE2}$  and  $\overline{CE2}$ ) are sampled by the same edge that samples  $\overline{ADSC}$  and  $\overline{BW1}$ – $\overline{BW4}$ ,  $\overline{BWE}$  and  $\overline{GW}$ . The  $\overline{ADV}$  line is held high for this clock edge to maintain the correct address for the internal write operation which will follow this second clock edge.

After the first cycle of the write burst, the state of  $\overline{BW1}$ - $\overline{BW4}$ ,  $\overline{BWE}$  and  $\overline{GW}$  determines whether the next cycle is a read or write cycle, and  $\overline{ADV}$  controls the advance of the address counter. The  $\overline{ADV}$  signal advances the address counter. This increments the address to the next available RAM address. You write the next word in the burst by taking  $\overline{ADV}$  low and presenting the write data at the positive edge of the clock. If  $\overline{ADV}$  is sampled low, the burst counter advances and the write data (which is sampled by the same clock) is written into the internal RAM during the time following the clock edge.

#### **Absolute Maximum Ratings**

Symbol	Rating	Com'l.	Unit
V <sub>TERM</sub>	Terminal Voltage with Respect to V <sub>SS</sub>	-0.5 to +4.6	V
T <sub>A</sub>	Operating Temperature	0 to +70	°C
T <sub>BIAS</sub>	Temperature Under Bias	-55 to +125	°C
T <sub>STG</sub>	Storage Temperature	-55 to +125	°C
I <sub>OUT</sub>	DC Output Current	100	mA

NOTE: 1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

# **Recommended DC Operating Conditions**

Symbol	Description	Min.	Тур.	Max.	Unit
V <sub>CC</sub>	Supply Voltage	3.1	3.3	3.6	V
V <sub>CCQ</sub>	Supply voltage	3.1	3.3	3.6	V
V <sub>SS</sub>	Supply Voltage	0	0	0	V
Commercial	Ambient Temperature	0	25	70	°C



# **DC Electrical Characteristics** ( $V_{\text{CC}}$ = 3.3V $\pm$ 0.3V, All Temperature Ranges)

Symbol	Description	Test Conditions	1	Min.	Max.	Unit
I <sub>LI</sub>	Input Leakage Current	$V_{IN} = 0V \text{ to } V_{CC}$		-2	2	μΑ
I <sub>LO</sub>	Output Leakage Current	Outputs Disabled, $V_{I/O} = 0V$ to $V_{CC}$		-2	2	μΑ
$V_{OL}$	Output Low Voltage	$V_{CC} = Min., I_{OL} = 8 \text{ mA}$			0.4	V
V <sub>OH</sub>	Output High Voltage	$V_{CC} = Min., I_{OH} = -5 \text{ mA}$		2.4	_	V
V <sub>IH</sub>	Input HIGH Voltage			2.0	3.6	V
V <sub>IL</sub>	Input LOW Voltage <sup>(1)</sup>		-	-0.3	0.8	V

NOTES: 1. Undershoots to -2.0 for 10 ns are allowed once per cycle.

2. MODE,  $\overline{\text{FT}}$  and ZZ pins have an internal pullup and exhibit an input leakage current of  $\pm 400 \, \mu A$ .

# **Power Supply Characteristics**

Symbol	Description	Test Conditions	-7 ns	-10 ns	-12 ns	-15 ns	Unit
I <sub>CC</sub>	Active Supply Current	Device Deselected $V_{IN} \le V_{IL}$ or $\ge V_{IH}$ , $I_{I/O} = 0$	315	230	210	190	mA
I <sub>SB</sub>	Standby Current:	Device Deselected $V_{IN} \le V_{IL}$ or $\ge V_{IH}$ , 0 MHz All inputs static	25	20	20	20	mA
I <sub>SB1</sub>	Standby Current:		5	3	3	3	mA
I <sub>SB2</sub>	Standby Current:		55	45	40	35	mA
I <sub>SB3</sub>	Sleep Mode Standby Current:	Device Deselected $ZZ \ge V_{CCQ} - 0.2V$	5	3	3	3	mA



# **Capacitance** ( $T_A = +25$ °C, f = 1.0 MHz)

Symbol	Parameter	Conditions	Max.	Unit
C <sub>IN</sub>	Input Capacitance	$V_{IN} = 0V$	6	pF
C <sub>OUT</sub>	Output Capacitance	V <sub>OUT</sub> = 0V	8	pF

NOTES: 1. Characterized values, not currently tested.

#### **AC Test Conditions**

Input pulse levels	V <sub>SS</sub> to 3.0V
Input rise and fall times	1.5 ns
Input timing reference levels	1.5V
Output reference levels	1.5V
Output load	See Figures 1 and 2

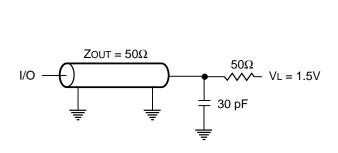


Figure 1. Output Load

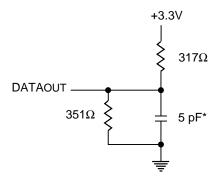


Figure 2. Output Load

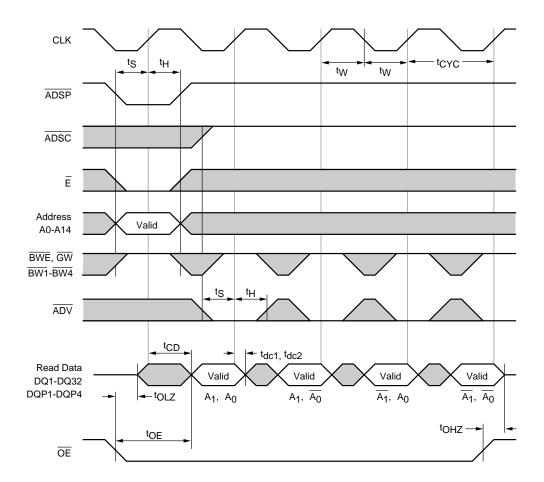
 $t_{CQ},\,t_{OLZ},\,t_{OHZ},\,t_{CZ}$ 



# **AC Electrical Characteristics**

Parameter	Symbol	-7 ns	-10 ns	-12 ns	-15 ns	Туре	Units
Cycle time	t <sub>CYC</sub>	12	16.7	20	25	Min.	ns
Clock access time (0 pF load)	t <sub>CQ0</sub>	8.5	9	11	13	Max.	ns
Clock to output valid (Std. load)	t <sub>CQ</sub>	9	10	12	14	Max.	ns
Clock to output invalid	t <sub>CQX</sub>	3	2	2	2	Min.	ns
Clock to output high-Z	t <sub>CHZ</sub>	5	2	2	2	Min.	ns
		12	16.7	20	25	Max.	
Clock pulse width high	t <sub>CH</sub>	4.5	6	6	6	Min.	ns
Clock pulse width low	t <sub>CL</sub>	4.5	6	6	6	Min.	ns
OE to output valid	t <sub>OE</sub>	5	6	6	6	Min.	ns
OE to output low-Z	t <sub>OLZ</sub>	0	0	0	0	Min.	ns
OE to output high-Z	t <sub>OHZ</sub>	5	6	6	6	Max.	ns
ZZ standby time	t <sub>ZZS</sub>	100	100	100	100	Max.	ns
ZZ recovery time	tzzrec	100	100	100	100	Min.	ns
SETUP TIMES							
Address	t <sub>AS</sub>	2.5	2.5	3	3	Min.	ns
Address status (ADSC, ADSP)	t <sub>AAS</sub>	2.5	2.5	3	3	Min.	ns
Address advance setup (ADV)	t <sub>AAS</sub>	2.5	2.5	3	3	Min.	ns
Write signals (BWx, GW)	t <sub>WS</sub>	2.5	2.5	3	3	Min.	ns
Data in	t <sub>DS</sub>	2.5	2.5	3	3	Min.	ns
Chip enables (CE, CE2, CE2)	t <sub>CES</sub>	2.5	2.5	3	3	Min.	ns
HOLD TIMES		•					
Address	t <sub>AH</sub>	0.5	0.5	0.5	0.5	Min.	ns
Address status (ADSC, DSP)	t <sub>ADSH</sub>	0.5	0.5	0.5	0.5	Min.	ns
Address advance (ADV)	t <sub>AAH</sub>	0.5	0.5	0.5	0.5	Min.	ns
Write eignals (BWx, GW)	t <sub>WH</sub>	0.5	0.5	0.5	0.5	Min.	ns
Data in	t <sub>DH</sub>	0.5	0.5	0.5	0.5	Min.	ns
Chip enables (CE, CE2, CE2)	t <sub>CEH</sub>	0.5	0.5	0.5	0.5	Min.	ns

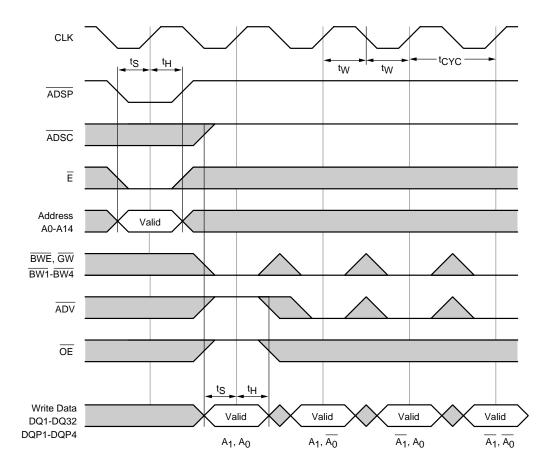
# **ADSP** Read Timing Diagram



#### NOTE:

1.  $\overline{E}$  is low when  $\overline{CE}$  = low, CE2 = high and  $\overline{CE2}$  = low.  $\overline{E}$  is high otherwise.

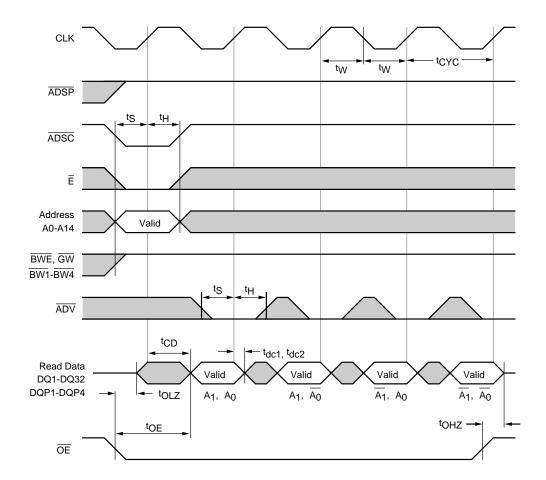
# **ADSP** Write Timing Diagram



#### NOTES:

- 1.  $\overline{\mathsf{E}}$  is low when  $\overline{\mathsf{CE}} = \mathsf{low}$ ,  $\mathsf{CE2} = \mathsf{high}$  and  $\overline{\mathsf{CE2}} = \mathsf{low}$ .  $\overline{\mathsf{E}}$  is high otherwise.
- 2. BWx and GW are ignored for the first cycle when ADSP initiates the burst. ADSP active loads a new address into the address-counter and forces the first cycle to be a read cycle.
- 3. OE is high before data input setup.

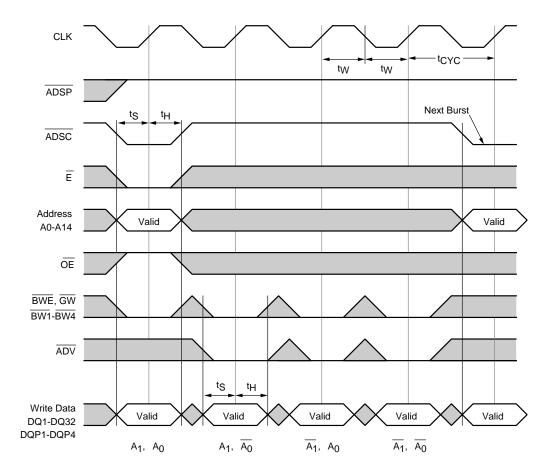
# **ADSC Read Timing Diagram**



#### NOTES: 1.

1.  $\overline{E}$  is low when  $\overline{CE}$  = low, CE2 = high and  $\overline{CE2}$  = low.  $\overline{E}$  is high otherwise.

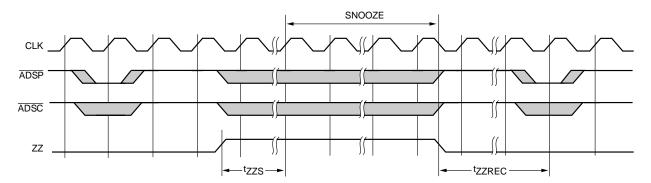
# **ADSP Write Timing Diagram**



#### NOTES:

- 1.  $\overline{E}$  is low when  $\overline{CE}$  = low, CE2 = high and  $\overline{CE2}$  = low.  $\overline{E}$  is high otherwise.
- 2. BWx and GW are ignored for the first cycle when ADSP initiates the burst. ADSP active loads a new address into the address counter and forces the first cycle to be a read cycle.
- 3.  $\overline{\text{OE}}$  is high before data input setup.

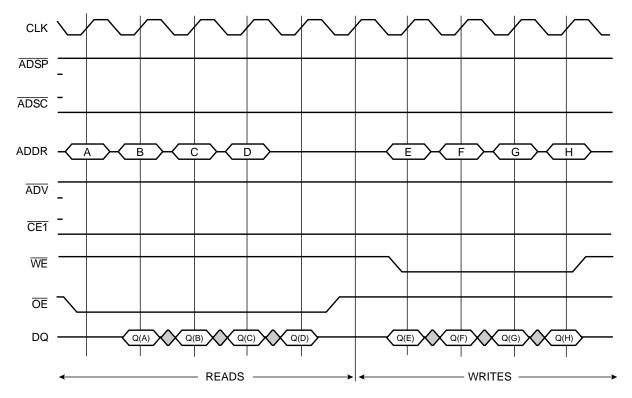
# **Sleep Mode Timing Diagram**



NOTES: 1. Data retention is guaranteed when ZZ is asserted and clock remains active.

2. ADSC and ADSP must not be asserted for at least 100 ns after leaving ZZ state.

# **Sequential Non-burst Read and Write Timing Diagram**



#### NOTES:

1.  $\overline{ADSP}$  = high,  $\overline{ADSC}$  = low,  $\overline{ADV}$  = high,  $\overline{CE1}$  = low.

2.  $H \ge V_{IH}$ ,  $L \le V_{IL}$ .

# **Ordering Information**

